

Evaluation of Latent Fingerprint Technologies (ELFT)





What are Latents?

- > Residual marks from fingers & palms
- > Also toe and footprints (all friction ridge skin) biquitous (found on almost all surfaces)
- > Arbitrarily **poor quality**
- >... but from *Very High Value Subjects*



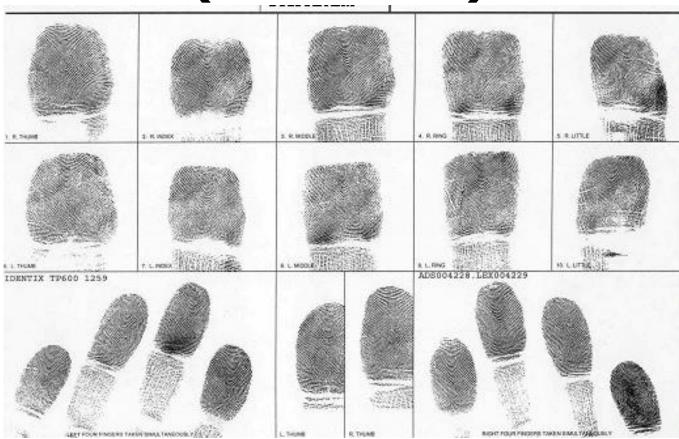


Conventional Fingerprints (not latents)

Rolls

Rolls

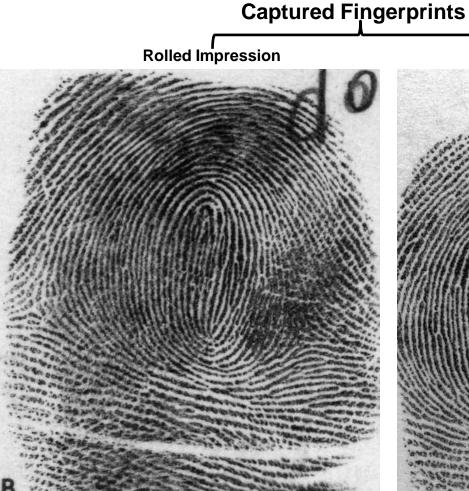
Slaps (Flats)





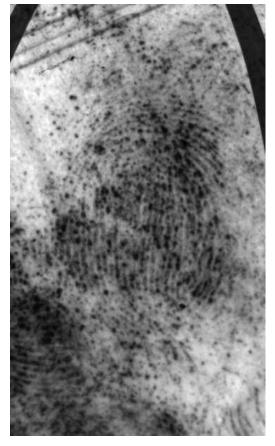


Latent vs. Conventional Prints





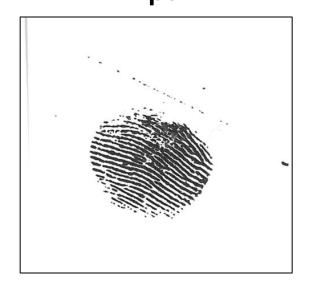
Latent Fingerprint (powder lift)





Why Are Latents Difficult?

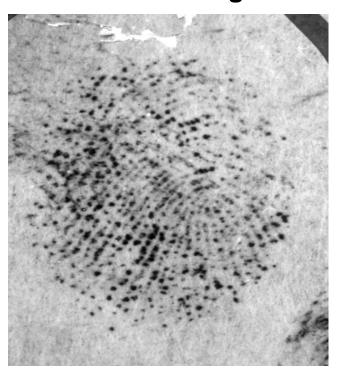
Tips



Smudges



Weathering





Why Are Latents Important?

Homeland Security



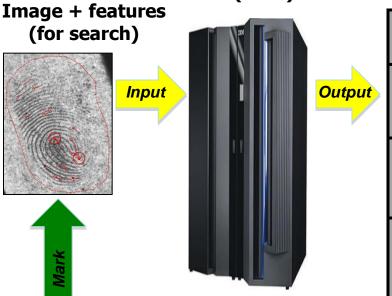


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Latent AFIS Technology

Automated Fingerprint Identification System (AFIS)





Latent Examiner

List of Candidates

Rank	Subject ID	Candidate Print
1	0733091	
2	1304033	
3	3952340	Match
20	0847121	

Image + features
(for comparison)







Latent Examiner



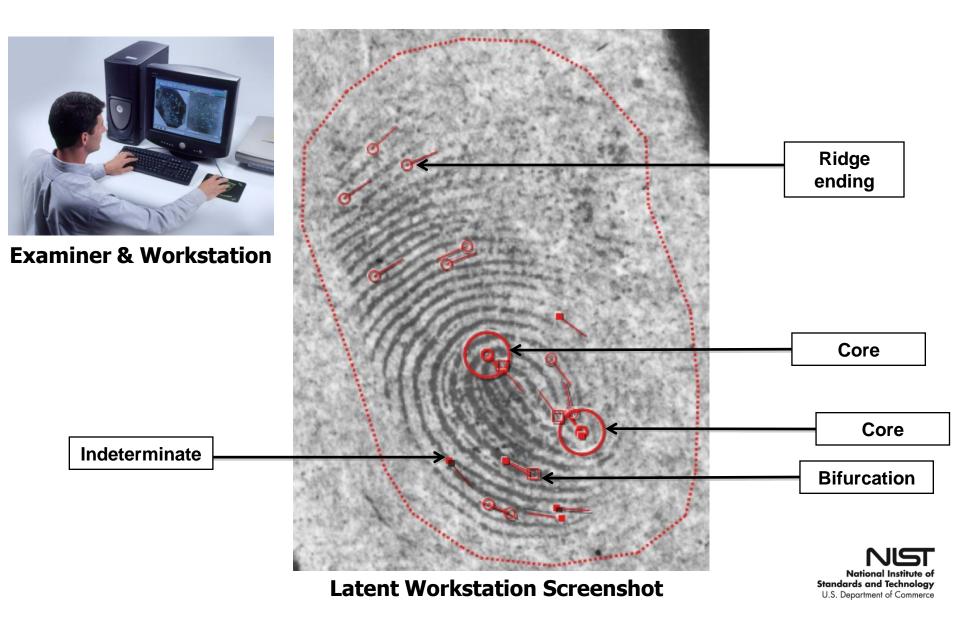
Latent AFIS Technology Problems?

> Manual workload ...





AFIS ID step: Manual Feature Markup





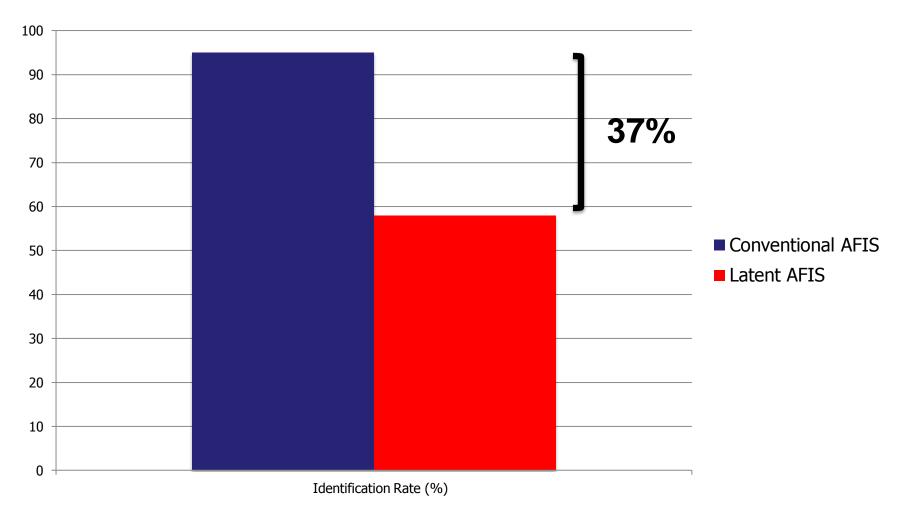
Latent AFIS Technology Problems?

- ➤ Manual processing ...
- > Accuracy ...





Conventional vs. Latent ID Rates







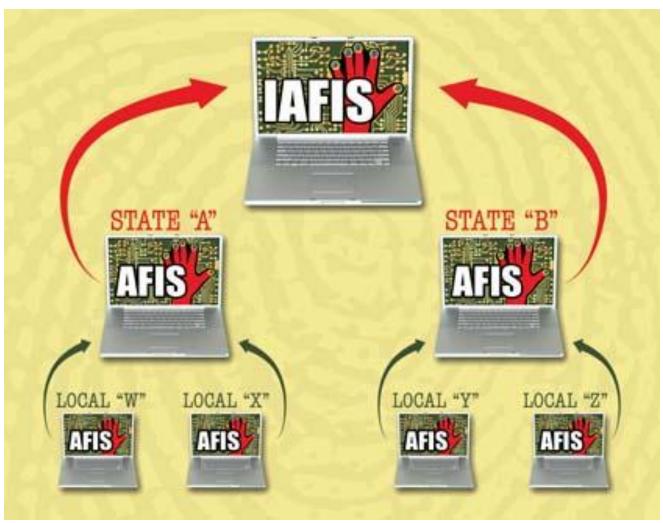
Latent AFIS Technology Problems?

- ➤ Manual processing ...
- > Accuracy ...
- Interoperability ...



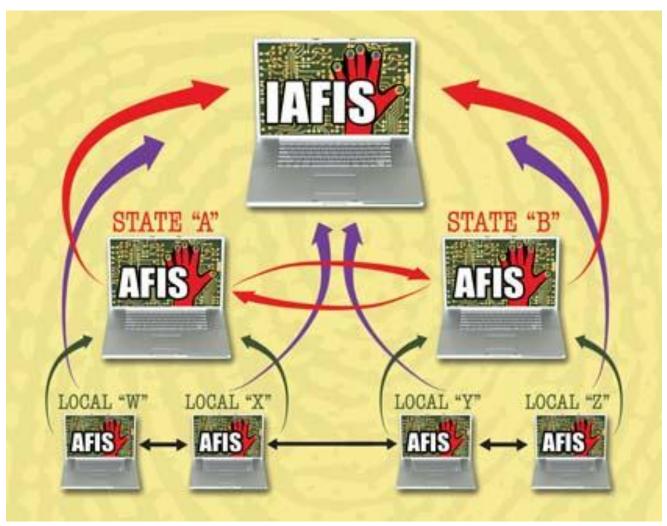


AFIS Interoperability: Now



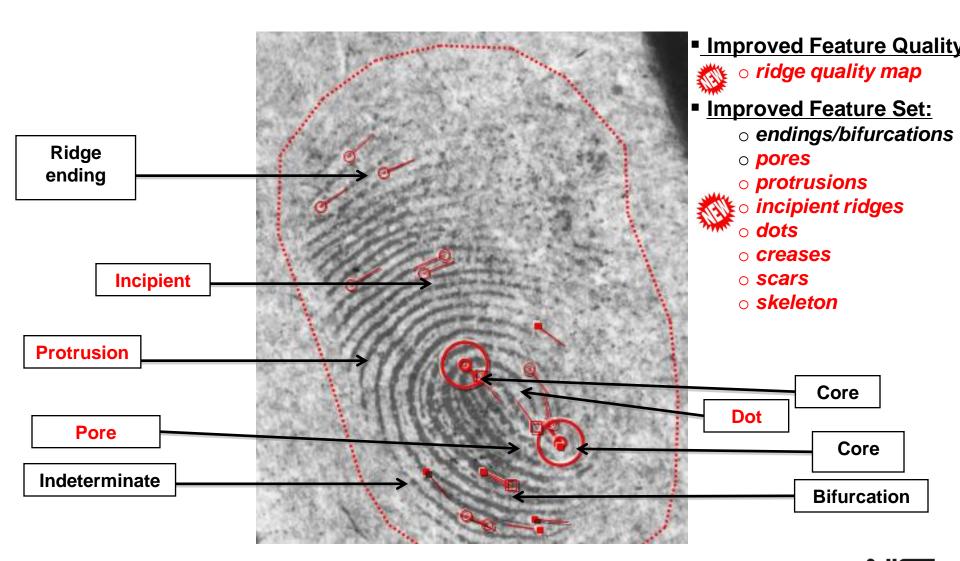


AFIS Interoperability: Future





Extended Feature Set (EFS)





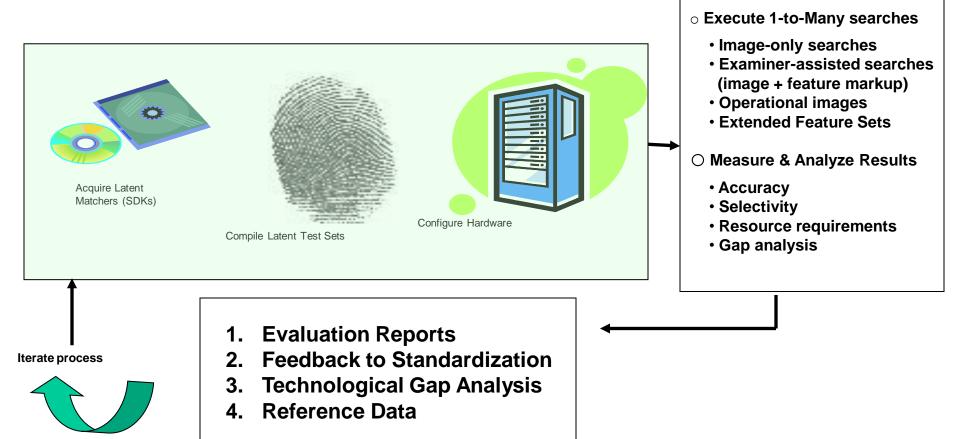
What is ELFT?

- Open evaluation of Automated Latent Fingerprint Identification Systems (AFIS) using automatic feature extraction and matching and standardized features hand-marked by human experts (EFS).
- Interactive effort between NIST and latent AFIS community to improve accuracy, promote interoperability, and reduce reliance on human examiners.





ELFT Testing Architecture





Evaluation Protocol



ELFT History

<i>></i> 2006	NIST Latent Fingerprint	Testing Workshop
	9 1	

≥ 2008	ELFT Phase II Evaluation
<i>/</i> 2 000	LLI I FIIGSC II EVAIGACIOII

> 2009	NIST Latent Fingerprint Testing Workshop

ELFT Phase II Miss Analysis Sessions

ELFT-EFS Public Challenge

> 2010 ELFT-EFS Evaluation #1

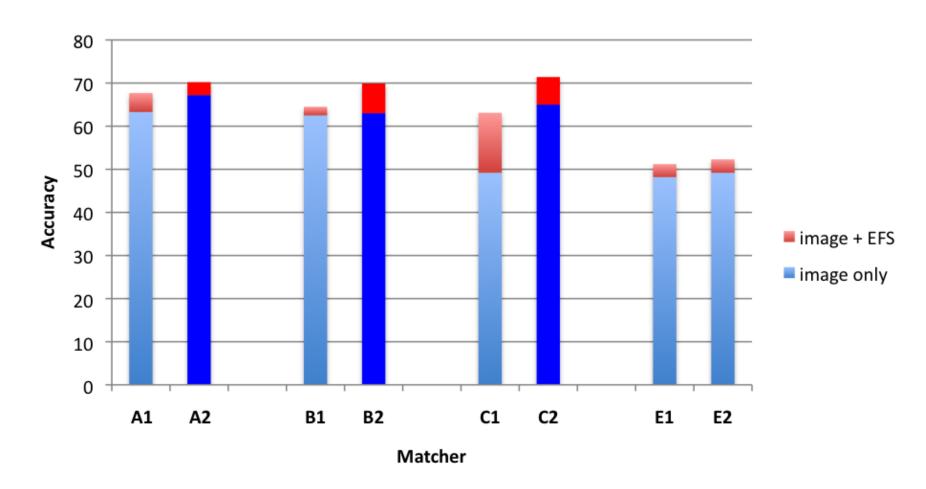
ELFT-EFS Miss Analysis Sessions

► 2011 ELFT-EFS Evaluation #2





Measured Accuracy Improvement (ELFT-EFS 1 vs. 2)







Customers and Community



- Developers & Researchers:
 - Measurement & failure analysis
 - Standards
 - Conferences, Journals
 - Reference data



Academia





- Users & Practitioners:
 - Performance rankings
 - System integration & tuning
 - Standards
 - Conferences, Workshops



National Institute of



Path Forward

- Develop best practices to reduce manual workload
 - lights-out processing of some operational workload
 - searching and encoding strategies
 - quality metrics
- Evaluate state-of-the-art latent fingerprint and (new) palmprint AFIS
 - interoperability testing (LITS/EFS profiles)
 - matcher and data fusion
 - candidate reduction techniques
- Expand scale of ELFT testing
 - operational scale tests
 - operational vs. research algorithms





Questions?



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